

**Notice of References Cited**

Application/Control No.

09/842,025

Applicant(s)/Patent Under  
Reexamination  
BU ET AL.

Examiner

Hai V. Nguyen

Art Unit

2142

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0044423	02-2005	Mellmer et al.	713/201
*	B	US-2002/0054579	05-2002	Miloslavsky, Alec	370/328
*	C	US-6,874,023	03-2005	Pennell et al.	709/224
*	D	US-6,654,735	11-2003	Eichstaedt et al.	707/3
*	E	US-6,571,259	05-2003	Zheng et al.	707/205
*	F	US-5,774,551	06-1998	Wu et al.	713/155
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.